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Low-voltage switchgear and controlgear – Part 2: Circuit-breakers (IEC 60947-2:2006)

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Low-voltage switchgear and controlgear Part 2: Circuit-breakers (IEC 60947-2:2006)

Appareillage à basse tension Partie 2: Disjoncteurs (CEI 60947-2:2006) Niederspannungsschaltgeräte Teil 2: Leistungsschalter (IEC 60947-2:2006)

This European Standard was approved by CENELEC on 2006-07-01. CENELEC members are bound to comply with the CEN/CENELEC Internal Regulations which stipulate the conditions for giving this European Standard the status of a national standard without any alteration.

Up-to-date lists and bibliographical references concerning such national standards may be obtained on application to the Central Secretariat or to any CENELEC member.

SIST EN 60947-2:2006

This European Standard exists in three official versions (English, Erench, German). A version in any other language made by translation under the responsibility of a CENELEC member into its own language and notified to the Central Secretariat has the same status as the official versions.

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CENELEC

European Committee for Electrotechnical Standardization Comité Européen de Normalisation Electrotechnique Europäisches Komitee für Elektrotechnische Normung

Central Secretariat: rue de Stassart 35, B - 1050 Brussels

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Foreword

The text of document 17B/1455/FDIS, future edition 4 of IEC 60947-2, prepared by SC 17B, Low-voltage switchgear and controlgear, of IEC TC 17, Switchgear and controlgear, was submitted to the IEC-CENELEC parallel vote and was approved by CENELEC as EN 60947-2 on 2006-07-01.

This European Standard supersedes EN 60947-2:2003.

The main changes introduced in EN 60947-2:2006 are an amendment to the verification of dielectric properties, the improvement of EMC clauses in Annexes B, F, J and M, and the addition of a new Annex O regarding instantaneous trip circuit-breakers.

The following dates were fixed:

-	latest date by which the EN has to be implemented at national level by publication of an identical national standard or by endorsement	(dop)	2007-04-01
-	latest date by which the national standards conflicting with the EN have to be withdrawn	(dow)	2009-07-01

This European Standard has been prepared under a mandate given to CENELEC by the European Commission and the European Free Trade Association and covers essential requirements of EC Directive EMC (89/336/CEE). See Annex ZZ.

Annexes ZA and ZZ have been added by CENELEC D PREVIEW

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Endorsement notice

The text of the International Standard (EC 60947-2:20068 was 7approved by CENELEC as a European Standard without any modification. 4cefc1c084a1/sist-en-60947-2-2006

In the official version, for Bibliography, the following notes have to be added for the standards indicated:

IEC 60112	NOTE	Harmonized as EN 60112:2003 (not modified).
IEC 60269-1	NOTE	Harmonized as EN 60269-1:1998 (not modified), new edition at draft stage.
IEC 60269-2-1	NOTE	Harmonized as HD 60269-2-1:2005 (not modified).
IEC 60269-3	NOTE	Harmonized as EN 60269-3:1995 (not modified), new edition at draft stage.
IEC 60439	NOTE	Harmonized as EN 60439 (Series) (not modified).
IEC 60947-3	NOTE	Harmonized as EN 60947-3:1999 (not modified).
IEC 60947-5-1	NOTE	Harmonized as EN 60947-5-1:2004 (not modified).

Annex ZA

(normative)

Normative references to international publications with their corresponding European publications

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE When an international publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

Publication	Year	Title	<u>EN/HD</u>	Year
IEC 60050-441 A1	1984 2000	International Electrotechnical Vocabulary (IEV) Chapter 441: Switchgear, controlgear and fuses	-	-
IEC 60051	Series	Direct acting indicating analogue electrical measuring instruments and their accessories	EN 60051	Series
IEC 60068-2-14 + A1 IEC 60068-2-30	1984 1986 2005	Environmental testing Part 2: Tests - Test N: Change of temperature Environmental testing Part 2-30: Tests - Test Db: Damp heat, cyclic (12 h + 12 h cycle)	EN 60068-2-30	1999 2005
IEC 60364	Series	Low-voltage electrical installations ndards.iteh.avcatalog/standards/sist/c8c4217b-e877-47b	4-9f76-	-
IEC 60364-4-41	2001	Electrical installations of buildings006 Part 4-41: Protection for safety - Protection against elctric shock	-	-
IEC 60695-2-10	2000	Fire hazard testing Part 2-10: Glowing/hot-wire based test methods - Glow-wire apparatus and common test procedure	EN 60695-2-10	2001
IEC 60695-2-11	2000	Fire hazard testing Part 2-11: Glowing/hot-wire based test methods - Glow-wire flammability test method for end-products	EN 60695-2-11	2001
IEC 60695-2-12	2000	Fire hazard testing Part 2-12: Glowing/hot-wire based test methods - Glow-wire flammability test method for materials	EN 60695-2-12	2001
IEC 60695-2-13	2000	Fire hazard testing Part 2-13: Glowing/hot-wire based test methods - Glow-wire ignitability test method for materials	EN 60695-2-13	2001
IEC/TR 60755 A1 A2	1983 1988 1992	General requirements for residual current operated protective devices	- - -	- -

Publication IEC 60898 (mod)	<u>Year</u> Series	<u>Title</u> Electrical accessories - Circuit-breakers for overcurrent protection for household and similar installations	<u>EN/HD</u> EN 60898	<u>Year</u> Series
IEC 60934	_1)	Circuit-breakers for equipment (CBE)	EN 60934	2001 ²⁾
IEC 60947-1	2004	Low-voltage switchgear and controlgear Part 1: General rules	EN 60947-1 + corr. November	2004 2004
IEC 60947-4-1 A1	2000 2002	Low-voltage switchgear and controlgear Part 4-1: Contactors and motor-starters - Electromechanical contactors and motor- starters	EN 60947-4-1 A1	2001 2002
IEC 61000-3-2 (mod) A1 + A2	2000 2001 2004	Electromagnetic compatibility (EMC) Part 3-2: Limits - Limits for harmonic current emissions (equipment input current up to and including 16 A per phase)	EN 61000-3-2 ³⁾ A2	2000 2005
IEC 61000-3-3	1994			1995
A1	2001	Electromagnetic compatibility (EMC) Part 3-3: Limits - Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems, for equipment with rated current \leq 16 A per phase and not subject to conditional	EN 61000-3-3 + corr. July A1	1995 1997 2001
	iT	econsection NDARD PREVIEV	W	
IEC 61000-4-2 A1 A2	1995 1998 2000	Electromagnetic compatibility (EMC) Part 4-2: Testing and measurement techniques - Electrostatic discharge immunity test <u>SIST EN 60947-2:2006</u>		1995 1998 2001
IEC 61000-4-3 A1	https://sta 2002 2002	ndards.iteh.ai/catalog/standards/sist/c8c4217b-e877-47b Electromagnetic compatibility/(EMC) Part 4-3: Testing and measurement techniques - Radiated, radio-frequency, electromagnetic field immunity test	4-9 1 76- EN 61000-4-3 ⁴⁾ A1	2002 2002
IEC 61000-4-4 A1 A2	1995 2000 2001	Electromagnetic compatibility (EMC) Part 4-4: Testing and measurement techniques - Electrical fast transient/burst immunity test	EN 61000-4-4 ⁵⁾ A1 A2	1995 2001 2001
IEC 61000-4-5 A1	1995 2000	Electromagnetic compatibility (EMC) Part 4-5: Testing and measurement techniques - Surge immunity test	EN 61000-4-5 A1	1995 2001
IEC 61000-4-6 A1	2003 2004	Electromagnetic compatibility (EMC) Part 4-6: Testing and measurement techniques - Immunity to conducted disturbances, induced by radio-frequency fields	-	-

²⁾ Valid edition at date of issue.

¹⁾ Undated reference.

 $^{^{3)}}$ EN 61000-3-2 + A2 are superseded by EN 61000-3-2:2006, which is based on IEC 61000-3-2:2005.

 $^{^{(4)}}$ EN 61000-4-3 + A1 are superseded by EN 61000-4-3:2006, which is based on IEC 61000-4-3:2006.

⁵⁾ EN 61000-4-4 + A1 + A2 are superseded by EN 61000-4-4:2004, which is based on IEC 61000-4-4:2004.

Publication IEC 61000-4-11	<u>Year</u> 2004	<u>Title</u> Electromagnetic compatibility (EMC) Part 4-11: Testing and measurement techniques - Voltage dips, short interruptions and voltage variations immunity tests	<u>EN/HD</u> EN 61000-4-11	<u>Year</u> 2004
IEC 61000-4-13	2002	Electromagnetic compatibility (EMC) Part 4-13: Testing and measurement techniques - Harmonics and interharmonics including mains signalling at a.c. power port, low frequency immunity tests	EN 61000-4-13	2002
IEC 61000-5-2	1997	Electromagnetic compatibility (EMC) Part 5: Installation and mitigation guidelines - Section 2: Earthing and cabling	-	-
IEC 61008-1 (mod) + A1 (mod)	1996 2002	Residual current operated circuit-breakers without integral overcurrent protection for household and similar uses (RCCB's) Part 1: General rules	EN 61008-1	2004
IEC 61009-1 + corr. May + A1 (mod)	1996 2003 2002	Residual current operated circuit-breakers with integral overcurrent protection for household and similar uses (RCBO's) Part 1: General rules	EN 61009-1 + corr. July	2004 2006
CISPR 11 (mod) +A1 (mod)	2003 2004	Industrial scientific and medical (ISM) radio- frequency equipment - Electromagnetic disturbance characteristics - Limits and methods of measurement	EN 55011	- 200X ⁶⁾
CISPR 22 (mod) A1	2005 1 <mark>2005</mark> sta	Information <u>technology</u> equipment - Radio disturbance characteristics methods of measurement/947-2-2006	EN 55022 4=9f76-	200X ⁶⁾ -

- 5 -

⁶⁾ To be published.

Annex ZZ

(informative)

Coverage of Essential Requirements of EC Directives

This European Standard has been prepared under a mandate given to CENELEC by the European Commission and the European Free Trade Association and within its scope the standard covers all relevant essential requirements as given in Article 4 of the EC Directive 89/336/EEC.

Compliance with this standard provides one means of conformity with the specified essential requirements of the Directive concerned.

WARNING: Other requirements and other EC Directives may be applicable to the products falling within the scope of this standard.

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INTERNATIONAL STANDARD



Fourth edition 2006-05

Low-voltage switchgear and controlgear -

Part 2: Circuit-breakers

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

LOW-VOLTAGE SWITCHGEAR AND CONTROLGEAR -

Part 2: Circuit-breakers

FOREWORD

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The main changes introduced in this new edition are an amendment to the verification of dielectric properties, the improvement of EMC clauses in Annexes B, F, J and M, and the addition of a new Annex O regarding instantaneous trip circuit-breakers.